

<b>Notice of References Cited</b>	Application/Control No. 10/781,495	Applicant(s)/Patent Under Reexamination VOLNAK, WILL	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,727,175	03-1998	Malone et al.	715/763
*	B	US-5,491,820	02-1996	Belove et al.	707/3
*	C	US-5,717,923	02-1998	Dedrick, Rick	707/102
*	D	US-5,761,656	06-1998	Ben-Shachar, Ofer	707/4
*	E	US-5,778,367	07-1998	Wesinger et al.	707/10
*	F	US-5,428,778	06-1995	Brookes, Cyril	707/5
*	G	US-5,721,897	02-1998	Rubinstein, Seymour I.	707/2
*	H	US-5,838,326	11-1998	Card et al.	715/775
*	I	US-5,761,662	06-1998	Dasan, Vasanthan S.	707/10
*	J	US-5,649,186	07-1997	Ferguson, Gregory J.	707/10
*	K	US-5,694,594	12-1997	Chang, Daniel	707/6
*	L	US-5,632,022	05-1997	Warren et al.	715/776
*	M	US-5,717,925	02-1998	Harper et al.	707/102

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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	U	
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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,623,652	04-1997	Vora et al.	707/10
*	B	US-5,408,655	04-1995	Oren et al.	715/501.1
*	C	US-5,931,907	08-1999	Davies et al.	709/218
*	D	US-5,446,891	08-1995	Kaplan et al.	707/2
*	E	US-5,845,278	12-1998	Kirsch et al.	707/3
*	F	US-5,835,905	11-1998	Pirolli et al.	707/3
*	G	US-5,435,004	07-1995	Cox et al.	707/205
*	H	US-5,206,951	04-1993	Khoyi et al.	719/315
*	I	US-5,523,942	06-1996	Tyler et al.	705/4
*	J	US-5,623,659	04-1997	Shi et al.	707/8
*	K	US-5,708,825	01-1998	Sotomayor, Bernardo Rafael	715/501.1
*	L	US-5,737,599	04-1998	Rowe et al.	707/10
*	M	US-5,913,215	06-1999	Rubinstein et al.	707/10

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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Examiner

Richard G. Keehn

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**U.S. PATENT DOCUMENTS**

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,781,785	07-1998	Rowe et al.	715/513
*	B	US-6,138,142	10-2000	Linsk, Steven J.	709/203
*	C	US-6,052,776	04-2000	Miki et al.	712/233
*	D	US-5,991,728	11-1999	DeBusk et al.	705/2
*	E	US-6,226,412	05-2001	Schwab, Barry H.	382/232
*	F	US-5,682,535	10-1997	Knudsen, Helge	717/117
*	G	US-6,557,102	04-2003	Wong et al.	713/176
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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